

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/592,959	TAKEZAWA, HIDEHARU	
		Examiner	Art Unit	Page 1 of 1
		Jacob Buchanan	1795	

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0031710 A1	03-2002	Kezuka et al.	429/303
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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